Search Notes



Application	/Control	No.
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Applicant(s)/Patent under Reexamination

ZDEBLICK ET AL.

Art Unit

Examiner
Yun H. Lee

10/764,429

3766

SEARCHED				
Class	Subclass	Date	Examiner	
600	523	7/13/2006	YHL	
607	4,9,17-28	7/13/2006	YHL	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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PG Pub	Search	7/13/2006	YHL	

SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
EAST Search	7/13/2006	YHL
Inventor Name Search	11/13/2006	YHL
Allowability discussed with Ken Schaetzle	11/13/2006	YHL